

**Search Notes**

Application/Control No.

10/672,389

Examiner

Chuck Huynh

Applicant(s)/Patent under  
Reexamination

YUKIE ET AL.

Art Unit

2683

**SEARCHED**

Class	Subclass	Date	Examiner
455	557	7/11/2005	CH
455	552.1	7/11/2005	CH
455	426.1	7/11/2005	CH
455	442	7/11/2005	CH
445	437	7/11/2005	CH
455	461	7/12/2005	CH
379	1.03	7/12/2005	CH
370	338	7/12/2005	CH
370	334	7/12/2005	CH
375	222	7/12/2005	CH

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Class/Subclass	7/11/2005	CH
IDS	7/11/2005	CH